

SCANFLEX® II BLADE 4

Multifunctional JTAG/Boundary Scan Controller



- · high-performance controller for embedded test and programming
- \cdot outstanding flexibility through multifunctional I/O channels and FPGA instrumentation for mixed-signal and high-speed test
- · high modularity and scalability through configurable TAP interface cards and additional I/O modules
- · integrated compact unit controllable via USB 3.0 and GBit LAN







Parameters	
number of TAP slots	4 (independent and individually configurable with TAP plug-in card)
maximum TCK frequency	20/50/100 MHz (adjustable via software)
parallel I/O channels	64 mixed-signal channels combined with FPGA, individually configurable as Input, Output, Tri-State, via software programmable V₁₀ 0.9-3.6 V (8 groups with 8 I/O)
maximum number of I/O modules	30 modules via external SFX carrier
integrated technologies	SPACE™, HYSCAN™, ADYCS™, ChipVORX®, FastScale™

Embedded test





Embedded programming

- high-speed programming of Flash components like NAND, NOR, SPI, I²C, eMMC etc. (also via I/O)
- universal programming of microcontrollers

SCANFLEX® II BLADE

Flexible controller for embedd test and programming

Software

- integrated into Embedded

Expandability

- support of up to 30 parallel controlled SCANFLEX® I/O modules
- scalable number of one to
- interfaces for additional debug and control components

Adaptability

- transmission over long distances of up to four meter to the target without TCK reduction or transmission problems

Made in Germany



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